

<b>Notice of References Cited</b>	Application/Control No. 10/532,448	Applicant(s)/Patent Under Reexamination HABERLAND, UDO	
	Examiner Andrew Hwa S. Lee	Art Unit 2886	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,528,367	06-1996	Putnam et al.	356/480
*	B	US-6,977,720	12-2005	Baney et al.	356/73.1
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	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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